IGBT

TRENCHSTOP™ IGBT3 Chip

SIGC32T120R3LE

Data Sheet

Industrial Power Control

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SIGC32T120R3LE

TRENCHSTOP™ IGBT3 Chip

Features:

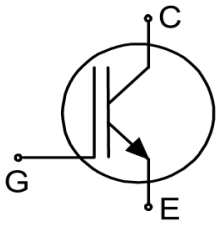
- 1200V trench & field stop technology
- Low turn-off losses
- Short tail current
- Positive temperature coefficient
- Easy paralleling

Recommended for:

- Power modules

Applications:

- Drives



Chip Type	V_{CE}	I_{Cn} [1]	Die Size	Package
SIGC32T120R3LE	1200V	25A	6.5mm x 4.87mm	Sawn on foil

Mechanical Parameters

Die size		6.5 x 4.87	mm^2
Emitter pad size		See chip drawing	
Gate pad size		1.139 x 1.139	
Area total		31.665	
Thickness		120	µm
Wafer size		200	mm
Maximum possible chips per wafer		864	
Passivation frontside		Photoimide	
Pad metal		3200nm AlSiCu	
Backside metal		Ni Ag – system To achieve a reliable solder connection it is strongly recommended not to consume the Ni layer completely during production process	
Die bond		Electrically conductive epoxy glue and soft solder	
Wire bond		Al, ≤500µm	
Reject ink dot size		∅ 0.65mm; max. 1.2mm	
Storage environment	for original and sealed MBB bags	Ambient atmosphere air, temperature 17°C – 25°C, <6 months	
	for open MBB bags	Acc. to IEC62258-3: atmosphere >99% Nitrogen or inert gas, humidity <25%RH, temperature 17°C – 25°C, <6 months	

[1] Nominal collector current at T_C=100°C for chip packaged in TO packages, see application example cited on page 5.

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T_{vj}=25°C	V_{CE}	1200	V
DC collector current, limited by $T_{vj\ max}$ [2]	I_C	-	A
Pulsed collector current, t_p limited by $T_{vj\ max}$ [3]	$I_{C,puls}$	75	A
Gate-emitter voltage	V_{GE}	±20	V
Junction temperature range	T_{vj}	-55 ... +175	°C
Operating junction temperature	T_{vj}	-55 ... +150	°C
Short circuit data [3] / [4] V_{GE}=15V, V_{CC}=900V, T_{vj}=125°C	t_{sc}	10	µs
Reverse bias safe operating area [3] (RBSOA)	$I_{C,max}$=50A, $V_{CE,max}$=1200V, T_{vj}≤125°C		

Static Characteristics (tested on wafer), T_{vj}=25°C

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-emitter breakdown voltage	$V_{(BR)CES}$	V_{GE}=0V, I_C=0.5mA	1200	-	-	V
Collector-emitter saturation voltage	V_{CEsat}	V_{GE}=15V, I_C=25A	1.4	1.7	2.1	
Gate-emitter threshold voltage	$V_{GE(th)}$	I_C=1mA, V_{GE}=V_{CE}	5.0	5.8	6.5	
Zero gate voltage collector current	I_{CES}	V_{CE}=1200V, V_{GE}=0V	-	-	3.48	µA
Gate-emitter leakage current	I_{GES}	V_{CE}=0V, V_{GE}=20V	-	-	600	nA
Integrated gate resistor	r_G			8		Ω

Electrical Characteristics [3]

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-emitter saturation voltage	V_{CEsat}	V_{GE}=15V, I_C=25A, T_{vj}=150°C	-	2.2	-	V
Input capacitance	C_{ies}	V_{CE}=25V, V_{GE}=0V, f=1MHz T_{vj}=25°C	-	1860	-	pF
Reverse transfer capacitance	C_{res}		-	82	-	

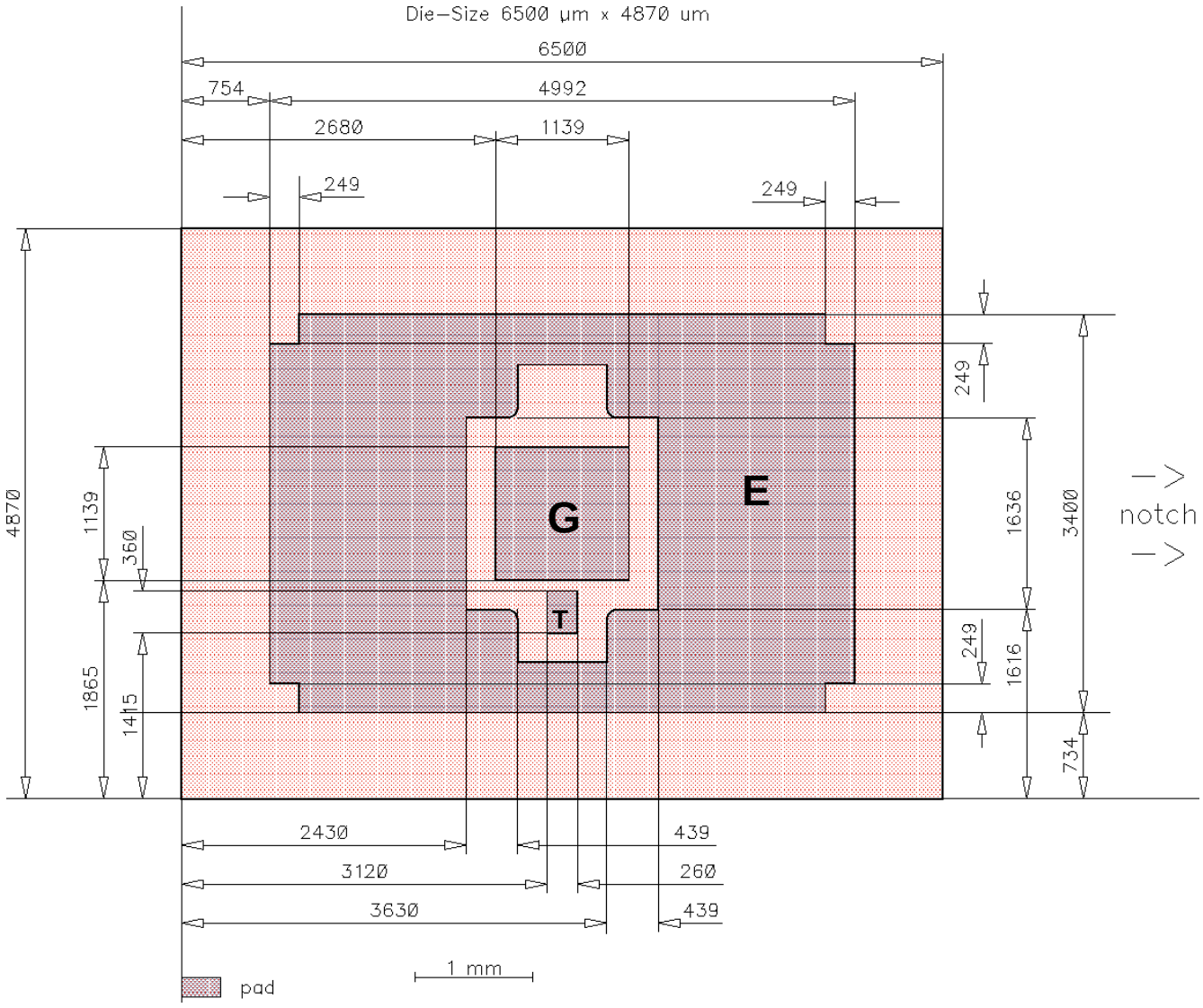
[2] Depending on thermal properties of assembly.
[3] Not subject to production test - verified by design/characterization.
[4] Allowed number of short circuits: <1000; time between short circuits: >1s.

Further Electrical Characteristics

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

Application example	IGW25T120	Rev. 2.4

Chip Drawing



E = Emitter
G = Gate
T = Test pad do not contact

Bare Die Product Specifics

Test coverage at wafer level cannot cover all application conditions. Therefore it is recommended to test all characteristics which are relevant for the application at package level, including RBSOA and SCSOA.

Description

AQL 0.65 for visual inspection according to failure catalogue
Electrostatic Discharge Sensitive Device according to MIL-STD 883

Revision History

Revision	Subjects (major changes since last revision)	Date
2.0	Release of final datasheet	31.01.2011
2.1	Additional basic types L7641N, L7641U, L7641F	27.06.2014
2.2	Minor changes, chip drawing	06.02.2015
2.3	Update disclaimer	19.08.2015

Relevant Application Notes

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